

LightTrans & PhotonicNet Webinar, 04.02.2021

Flat Optics – about Freeform, Fresnel, Diffractive and Meta Lenses

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- Professor at University of Jena, Applied Computational Optics, IAP (1996)
- Co-Founder and President of LightTrans GmbH (1999)
- Co-Founder and President of Wyrowski Photonics (2014)







Co-Founder and CEO: Christian Hellmann

Physical Optics Modeling and Design



Fast Physical Optics Modeling and Design Software



Physical Optics with VirtualLab Fusion

... learning from Max Born and Emil Wolf



Interference and Diffraction of Light







How to realize a seamless transition between ray and physical optics?

Geometric Branch of Physical Optics





3.1 Approximation for very short wavelengths

THE electromagnetic field associated with the propagation of visible light is characterized by very rapid oscillations (frequencies of the order of 10^{14} s⁻¹) or, what amounts to the same thing, by the smallness of the wavelength (of order 10^{-5} cm). It may therefore be expected that a good first approximation to the propagation laws in such cases may be obtained by a complete neglect of the finiteness of the wavelength. It is found that for many optical problems such a procedure is entirely adequate; in fact, phenomena which can be attributed to departures from this approximate theory (socalled diffraction phenomena, studied in Chapter VIII) can only be demonstrated by means of carefully conducted experiments.

The branch of optics which is characterized by the neglect of the wavelength, i.e. that corresponding to the limiting case $\lambda_0 \rightarrow 0$, is known as geometrical optics,* since in this approximation the optical laws may be formulated in the language of geometry. The energy may then be regarded as being transported along certain curves (light rays). A physical model of a pencil of rays may be obtained by allowing the light from a source of negligible extension to pass through a very small opening in an opaque screen. The light which reaches the space behind the screen will fill a region the boundary of which (the edge of the pencil) will, at first sight, appear to be sharp. A more careful examination will reveal, however, that the light intensity near the boundary varies rapidly but continuously from darkness in the shadow to lightness in the illuminated region, and that the variation is not monotonic but is of an oscillatory character, manifested by the appearance of bright and dark bands, called diffraction fringes. The region in which this rapid variation takes place is only of the order of magnitude of the wavelength. Hence, as long as this magnitude is neglected in comparison with the dimensions of the opening, we may speak of a sharply bounded pencil of rays.[†] On reducing the size of the opening down to the dimensions of the

[†] That the boundary becomes sharp in the limit as λ₀ → 0 was first shown by G. Kirchhoff, *Vorleaungen û. Math. Phys.*, Vol. 2 (*Mathematische Optik*) (Leipzig, Tuebner, 1891), p. 33. See also B. B. Baker and E. T. Copson, *The Mathematical Theory of Hwygens "Principle* (Oxford, Clarendon Press, 2nd edition, 1950), p. '99, and A. Sommerfeld, *Optics* (New York, Academic Press, 1954), §35.

^{*} The historical development of geometrical optics is described by M. Herzberger, Snuhlenguti (Berlin, Springer, 1931), p. 179; Z. Instrumentenkunde, 52 (1932), 429–435, 485–493, 534–542, C. Carthéodory, Geometrische Optik (Berlin, Springer, 1937) and E. Mach, The Principles of Physical Optics: A Historical and Philosophical Treatment (First German edition 1913, English translation: London, Methuen, 1926; reprinted by Dover Publications, New York, 1953).

Geometric Branch of Physical Optics



We have seen that, when the wavelength is sufficiently small, the transport of energy may be represented by means of a simple hydrodynamical model which may be completely described in terms of the real scalar function S, this function being a solution of the eikonal equation (15). According to traditional terminology, one understands by geometrical optics this approximate picture of energy propagation, using the concept of rays and wave-fronts. In other words polarization properties are excluded. The reason for this restriction is undoubtedly due to the fact that the simple laws of geometrical optics concerning rays and wave-fronts were known from experiments long before the electromagnetic theory of light was established. It is, however, possible, and from our point of view quite natural, to extend the meaning of geometrical optics to embrace also certain geometrical laws relating to the propagation of the 'amplitude vectors' e and h. These laws may be easily deduced from the wave equations (10)–(17).

Since S satisfies the eikonal equation, it follows that $\mathbf{K} = 0$, and we see that when k_0 is sufficiently large (λ_0 small enough), only the \mathbf{L} -terms need to be retained in (16) and (17). Hence, in the present approximation, the amplitude vectors and the eikonal are connected by the relations $\mathbf{L} = 0$. If we use again the operator $\partial/\partial \mathbf{r}$ introduced by (38), the equations $\mathbf{L} = 0$ become

$$\frac{\partial \mathbf{e}}{\partial \tau} + \frac{1}{2} \left(\nabla^2 S - \frac{\partial \ln \mu}{\partial \tau} \right) \mathbf{e} + (\mathbf{e} \cdot \operatorname{grad} \ln n) \operatorname{grad} S = 0, \tag{41}$$
$$\frac{\partial \mathbf{h}}{\partial \tau} + \frac{1}{2} \left(\nabla^2 S - \frac{\partial \ln \varepsilon}{\partial \tau} \right) \mathbf{h} + (\mathbf{h} \cdot \operatorname{grad} \ln n) \operatorname{grad} S = 0. \tag{42}$$

These are the required *transport equations* for the variation of e and h along each ray. The implications of these equations can best be understood by examining separately the variation of the magnitude and of the direction of these vectors.

* It has been shown by M. Kline, Comm. Pure and Appl. Maths., 14 (1961), 473 that the intensity ratio (40) may be expressed in terms of an integral which involves the principal radii of curvature of the associated wavefronts. Kline's formula is a natural generalization, to inhomogeneous media, of the formula (34). See also M. Kline and I. W. Kay, *ibid.* 184.

"According to traditional terminology, one understands by geometrical optics this picture approximate of energy propagation, using the concept of rays wave-fronts. and In other words polarization properties are excluded. The reason for this restriction is undoubtedly due to the fact that the simple laws of geometrical optics concerning rays and wave-fronts were known from experiments long before the electromagnetic theory of light was established. It is, however, possible, and from our point of view quite natural, to extend the meaning of geometrical optics to embrace also certain geometrical laws relating to the propagation of the 'amplitude vectors' E and H."

page 125



How to realize a seamless transition between ray and physical optics?

We follow Max Born's and Emil Wolf's point of view!



Field solvers, e.g., FDTD, FEM, FMM

How to realize a seamless transition between ray and physical optics?

We follow Max Born's and Emil Wolf's point of view!

"... to extend the meaning of geometrical optics to embrace also certain geometrical laws relating to the propagation of the 'amplitude vectors' E and H."



Field Tracing:

- Connecting rigorous and approximated field solvers in different regions of the system.
- VirtualLab Fusion is a platform for in-built and customized solvers.





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- All examples in webinar are done with the in-house version of VirtualLab Fusion!
- Typical speed of modeling and design tasks in talk: a few seconds to < 1 min
- Features already available or to be released in 2021.



Freeform and Flat Optics: What? Why? How?

Freeform and Flat Optics



Freeform and Flat Optics



Freeform and Flat Optics



Flat Optics Fabrication: Planar Surfaces



Freeform and Flat Optics: Why?



Optical Surfaces A Revolution in Imaging **Optical Design** Kevin P. Thompson and Jannick P. Rolland **OPN Optics & Photonics News**,

June 2012 June 2012



https://www.nbcnews.com/mach/science/

Freeform and flat optics introduce new design freedoms! Strongly dependent on available

fabrication and further development.

Freeform and Flat Optics: Why?



Freeform and flat optics introduce new design freedoms:

- Improve performance
- Reduce size and weight
- Less components
- Cost reduction

. . .

• Add new functionality, e.g., bifocal lenses, polarization dependency, ...

Freeform and Flat Optics: Why?



Freeform and flat optics introduce new design freedoms:

- Improve performance
- Reduce size and weight
- Less components
- Cost reduction
- Add new functionality, e.g., bifocal lenses, polarization dependency, ...

"Is it possible to replace a bulky glass system by one metalens" ?

... see end of webinar!

Freeform and Flat Optics: How?



• Flat optics requires physical optics modeling.



Freeform and Flat Optics: How?



- Flat optics requires physical optics modeling.
- Typically, the large number of freeform and layer parameters is challenging for conventional parametric optimization.

Physical optics may give a fresh view and new ideas to optical design beyond conventional routines.

Freeform and Flat Optics: How?



VirtualLab Fusion 2021

Optical Design Scenarios

... formulated by physical optics

Light Representation in Physical Optics

- In physical optics light is described by vectorial electromagnetic fields.
- The electric field is denoted by the three components

$$\boldsymbol{E}(\boldsymbol{r},\omega) = \begin{pmatrix} E_x(\boldsymbol{r},\omega) \\ E_y(\boldsymbol{r},\omega) \\ E_z(\boldsymbol{r},\omega) \end{pmatrix} \cdot \qquad \lambda = \frac{2\pi}{\omega} n$$

- The components typically possess a common wavefront phase $\psi({\pmb r},\omega)$ and we write

$$oldsymbol{E}(oldsymbol{r},\omega) = oldsymbol{U}(oldsymbol{r},\omega) \exp\left(\mathrm{i}\psi(oldsymbol{r},\omega)
ight) = egin{pmatrix} U_x(oldsymbol{r},\omega) \ U_y(oldsymbol{r},\omega) \ U_z(oldsymbol{r},\omega) \end{pmatrix} \exp\left(\mathrm{i}\psi(oldsymbol{r},\omega)
ight),$$

with $(\ell = x, y, z)$

$$\psi(\boldsymbol{r},\omega) = \arg \left(E_{\ell}(\boldsymbol{r},\omega) \right) - \arg \left(U_{\ell}(\boldsymbol{r},\omega) \right).$$



1831 – 1879

$$\nabla \times \boldsymbol{E}(\boldsymbol{r}, \omega) = i\omega\mu_0 \boldsymbol{H}(\boldsymbol{r}, \omega)$$
$$\nabla \times \boldsymbol{H}(\boldsymbol{r}, \omega) = -i\omega\epsilon_0 \check{\epsilon}_r(\boldsymbol{r}, \omega) \boldsymbol{E}(\boldsymbol{r}, \omega)$$
$$\nabla \cdot \left(\check{\epsilon}_r(\boldsymbol{r}, \omega) \boldsymbol{E}(\boldsymbol{r}, \omega)\right) = 0$$
$$\nabla \cdot \boldsymbol{H}(\boldsymbol{r}, \omega) = 0$$



 $E_x(\boldsymbol{\rho}) = |U_x(\boldsymbol{\rho})| \exp\left(\mathrm{i} \arg(U_x)(\boldsymbol{\rho})\right) \exp\left(\mathrm{i} \psi(\boldsymbol{r},\omega)\right)$



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Design Scenarios: Field Transformation



Design Scenarios: Field Transformation



Design Scenarios: Field Transformation



Scenarios:

Single-field design One input and output field only ($\alpha = 1$) Multi-field design Set of N_{α} input and output fields ($\alpha = 0, \dots, N_{\alpha} - 1$)

Monochromatic or polychromatic design

Design Scenarios: Imaging



Monochromatic or polychromatic design
Design Scenarios: Light Shaping



Manipulation and Control of Input Fields



How to achieve the specified transformations with sufficient accuracy?

Manipulation and Control of Input Fields



Major manipulations of fields on their way through system:

- Wavefront phase control: $\psi^{in} \to \ldots \psi_j \ldots \to \psi^{out}$
- Irradiance shaping: $E_{e}^{in} \rightarrow \ldots E_{e,j} \ldots \rightarrow E_{e}^{out}$

Proposed Design Workflow

FUNCTIONAL DESIGN

Design the system by introducing functional components to achieve the demanded system functionality.

STRUCTURAI DESIGN

Replace functional components by smooth surface or flat optics components.

MODELING & EVALUATION

Model the system with ray tracing and physical optics. Evaluate the performance by suitable detectors and merit functions.

FURTHER OPTIMIZATION

Use the modeling techniques to further optimize the system by, e.g., parametric optimization.

SYSTEM TOLERANCING

Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

FABRICATION DATA

Use the modeling techniques to further optimize the system by, e.g. parametric optimization.

Single Field Scenario





Wavefront Response Component (WRC)



Domain and Irradiance Matching



Domain and irradiance matching:

The domains $X(U^{\text{in}})$ and $X(U^{\text{out}})$ should match as good as possible on the plane *P*.

The irradiances E_{e}^{in} and E_{e}^{out} should match as good as possible on the plane P.

Domain and Irradiance Matching



The domains $X(U^{\text{in}})$ and $X(U^{\text{out}})$ should match as good as possible on the plane *P*.

The irradiances E_{e}^{in} and E_{e}^{out} should match as good as possible on the plane P.

Domain and Irradiance Matching



$$P_{1}$$

$$n_{1}$$

$$n_{2}$$
Input field
$$E^{\text{in,d}}(\rho) = U^{\text{in,d}}(\rho) \exp(i\psi^{\text{in,d}}(\rho))$$
with index "d" for design field
$$\psi^{\text{in,d}}(\rho \in P_{1})$$

Output field

$$E^{\text{out,d}}(\rho) = U^{\text{out,d}}(\rho) \exp(i\psi^{\text{out,d}}(\rho))$$

 $\psi^{\mathrm{out,d}}(\boldsymbol{\rho}\in P)$

$$\begin{array}{c} P_{1}\\ n_{1} \\ n_{2} \end{array}$$
Input field
$$E^{\mathrm{in,d}}(\rho) = U^{\mathrm{in,d}}(\rho) \exp\left(\mathrm{i}\psi^{\mathrm{in,d}}(\rho)\right)$$
with index "d" for design field
$$\psi^{\mathrm{in,d}}(\rho \in P_{1})$$

Output field

$$E^{\text{out,d}}(\rho) = U^{\text{out,d}}(\rho) \exp(i\psi^{\text{out,d}}(\rho))$$

 $\psi^{\mathrm{out,d}}(\boldsymbol{\rho}\in P)$





 $\psi^{\mathrm{shape}}(\rho)$ determined by domain/irradiance shaping algorithm.

Domain and Irradiance Matching: Light Shaping



 $\psi^{\rm shape}(\pmb{\rho})$ determined by domain/irradinace shaping algorithm.





Functional Design: Single Field



Wavefront Response Component

Wavefront design

Wavefront Response Component (combination)

• Irradiance shaping

Functional Design: Single Field





Wavefront Response Component

Wavefront design



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Wavefront Response Component (combination)

- Irradiance shaping
- Wavefront design

Example Focusing

Focusing Lens: Functional Design



Functional Design: Focusing (NA = 0.2)



Functional Design: Focusing (NA = 0.2) – Ray Tracing



Functional Design: Focusing (NA = 0.2) – Field Tracing



Field in Focus (False Color)



MTF

Beam Expander

Beam Expander: Scenario



Beam Expander: Scenario



Beam Expander: Functional Design



responses.

Beam Expander: Functional Design



- Let assume the given parameters are the expander ratio $\zeta = \rho^{\text{out}}/\rho^{\text{in}}$ and the distance Δz .
- A straightforward evaluation leads to the equations

$$R_{1} = \frac{\Delta z}{(\zeta - 1)}$$
$$R_{2} = -(\Delta z + R_{1})$$
$$NA = \frac{n}{\sqrt{1 + (\Delta z / \rho^{\text{out}})^{2}}}$$

for radii of the first and second spherical wavefront phase response and the related NA .

• Thus, the functional design results by analytical considerations to the wavefront phases:

$$\Delta \psi_1(\boldsymbol{\rho}, k_0) = k_0 n \sqrt{\|\boldsymbol{\rho}\|^2 + R_1^2}$$
$$\Delta \psi_2(\boldsymbol{\rho}, k_0) = -k_0 n \sqrt{\|\boldsymbol{\rho}\|^2 + R_2^2}$$

Beam Expander (1:5) – Functional Design: Ray Tracing



Beam Expander (1:5) – Functional Design: Output Beam



Amplitude after Beam Expander

Phase after Beam Expander

Beam Expander Combined with Light Shaping

Shaping Beam Expander: Scenario



Shaping Beam Expander: Scenario


Shaping Beam Expander: Functional Design





Irradiance (by field tracing)

Example Fiber Coupling

Scenario: Laser Diode Coupling Into Fiber

laser diode with astigmatism

- wavelength 405nm
- half divergent angle (1/e²): 8.74° x 15.63°
- astigmatism between y and x: -1 mm



Functional Design: Laser Diode Coupling Into Fiber

laser diode with astigmatism

- wavelength 405nm
- half divergent angle (1/e²): 8.74° x 15.63°
- astigmatism between y and x: -1 mm



Laser Diode Coupling Into Fiber: Ray Tracing



Laser Diode Coupling Into Fiber: Field Tracing



Proposed Design Workflow



Proposed Design Workflow

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Replace functional components by freeform or/and flat optics components.

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FURTHER OPTIMIZATION

Use the modeling techniques to further optimize the system by, e.g., parametric optimization.

SYSTEM TOLERANCING

Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

FABRICATION DATA

Use the modeling techniques to further optimize the system by, e.g. parametric optimization.

Structural Design

Single Field Scenario

Wavefront Response by Flat Optics



Wavefront Response by Flat Optics



How is it possible to realize a wavefront phase response by a **THIN** layer?

Example 1D wavefront phase







1





$\psi(x)$ $\psi(x)$ 40 40 $\psi(\mathbf{x})$ in rad 30 30 20 20 $1 = e^{i4\pi}, m = 2$ 10 $\psi(\mathbf{x})$ in rad -20 -10 10 20 30 -30 -20 -10 10 20 30 -30 0 0

Example 1D wavefront phase

$\psi(x)$ $\psi(x)$ 40 40 $\psi(\mathbf{x})$ in rad 30 30 20 20 $_{10}$ 1 = e^{i2 π}, m = 1 10 $\psi(\mathbf{x})$ in rad -20 -10 10 20 30 -30 -20 -10 10 20 30 -30 0 0

Example 1D wavefront phase







$\psi(x)$ $\psi(x)$ 40 40 $\psi(\mathbf{x})$ in rad 30 30 20 20 $_{10}$ 1 = e^{i2 π}, m = 1 10 $\psi(\mathbf{x})$ in rad -20 -10 10 20 30 -30 -20 -10 10 20 30 -30 0 0

Example 1D wavefront phase

Segmented Phase Manipulation

$\psi(x)$ $\psi(x)$ 40 40 $\psi(\mathbf{x})$ in rad 30 30 20 20 $1 = e^{i4\pi}, m = 2$ $-\psi(x)$ in rad ${}^{1}1 = e^{i2\pi}, m = 1$ 10 — x -40 -20 0 20 40 -20 -10 10 20 30 -30 0

Example 1D wavefront phase

Wavefront Response by Flat Optics



Wavefront Response of Surface + Structured Layer



What effects can be used to realize a wavefront phase response by a surface + structured layer?



$$\begin{split} \boldsymbol{E}^{\text{out}}(\boldsymbol{\rho}) &= \boldsymbol{\mathcal{B}}\!\!\left(\boldsymbol{\rho}' \mapsto \boldsymbol{E}^{\text{in}}(\boldsymbol{\rho}')\right)\!\left(\boldsymbol{\rho}\right) \\ &= \int \int_{X^{\text{in}}} \boldsymbol{\mathsf{B}}(\boldsymbol{\rho}, \boldsymbol{\rho}') \boldsymbol{E}^{\text{in}}(\boldsymbol{\rho}') \,\mathrm{d}x' \,\mathrm{d}y' \end{split}$$









Vectorial Field Response Operator: Local Integration



Vectorial Field Response Operator: Local Integration



$$= \int \int_{\boldsymbol{X} \subset \boldsymbol{X}^{\text{in}}} \mathbf{B}(\boldsymbol{\rho}, \boldsymbol{\rho}') \boldsymbol{E}^{\text{in}}(\boldsymbol{\rho}') \, \mathrm{d}x' \, \mathrm{d}y'$$



VirtualLab Fusion 2021 Local use of FMM/RCWA tested and in preparation

Vectorial Field Response Operator: Local Integration



Vectorial Field Response Operator: Pointwise



$$\begin{aligned} \boldsymbol{E}^{\text{out}}(\boldsymbol{\rho}) &= \boldsymbol{\mathcal{B}}(\boldsymbol{\rho}' \mapsto \boldsymbol{E}^{\text{in}}(\boldsymbol{\rho}'))(\boldsymbol{\rho}) \\ &= \int \int_{\boldsymbol{X} \subset \boldsymbol{X}^{\text{in}}} \boldsymbol{\mathsf{B}}(\boldsymbol{\rho}, \boldsymbol{\rho}') \boldsymbol{E}^{\text{in}}(\boldsymbol{\rho}') \, \mathrm{d}\boldsymbol{x}' \, \mathrm{d}\boldsymbol{y}' \end{aligned}$$

Vectorial Field Response: Pointwise



Field response: $\underline{B}(\rho')E^{\text{in}}(\rho') \mapsto E^{\text{out}}(\rho)$

with the field response matrix $\underline{\mathbf{B}}(oldsymbol{
ho}):\mathbb{R}^2
ightarrow\mathbb{C}^{3 imes 3}$

Vectorial Field Response: Pointwise



 $\begin{array}{ll} \textbf{U-field response:} \quad \underline{\textbf{b}}(\boldsymbol{\rho}') \boldsymbol{U}^{\mathrm{in}}(\boldsymbol{\rho}') \mapsto \boldsymbol{U}^{\mathrm{out}}(\boldsymbol{\rho}) \\ \\ \textbf{Wavefront phase response:} \quad \psi^{\mathrm{in}}(\boldsymbol{\rho}') + \Delta \psi(\boldsymbol{\rho}') \mapsto \psi^{\mathrm{out}}(\boldsymbol{\rho}) \end{array}$

Vectorial Field Response: Pointwise



U-field response: $\underline{\mathbf{b}}(oldsymbol{
ho}')oldsymbol{U}^{\mathrm{in}}(oldsymbol{
ho}')\mapstooldsymbol{U}^{\mathrm{out}}(oldsymbol{
ho})$

Wavefront phase response: $\psi^{in}(\rho') + \Delta \psi(\rho') \mapsto \psi^{out}(\rho)$

Basic arguments and methods remain valid for

- Curved surfaces
- Transmission and reflection

Vectorial Field Response: Surface w/o Layer



U-field response: $\underline{\mathbf{b}}(\boldsymbol{\rho}') \boldsymbol{U}^{\text{in}}(\boldsymbol{\rho}') \mapsto \boldsymbol{U}^{\text{out}}(\boldsymbol{\rho})$ Wavefront phase response: $\psi^{\text{in}}(\boldsymbol{\rho}') + \Delta \psi(\boldsymbol{\rho}') \mapsto \psi^{\text{out}}(\boldsymbol{\rho})$


U-field response: $\underline{\mathbf{b}}(\boldsymbol{\rho}') \boldsymbol{U}^{\mathrm{in}}(\boldsymbol{\rho}') \mapsto \boldsymbol{U}^{\mathrm{out}}(\boldsymbol{\rho})$ Wavefront phase response: $\psi^{\mathrm{in}}(\boldsymbol{\rho}') + \Delta \psi(\boldsymbol{\rho}') \mapsto \psi^{\mathrm{out}}(\boldsymbol{\rho})$

- Response given by Fresnel's equations
- Field response: S matrix



U-field response: $\underline{\mathbf{b}}(\boldsymbol{\rho}', \hat{\boldsymbol{s}}^{\text{in}}(\boldsymbol{\rho}')) U^{\text{in}}(\boldsymbol{\rho}') \mapsto U^{\text{out}}(\boldsymbol{\rho})$ Wavefront phase response: $\psi^{\text{in}}(\boldsymbol{\rho}') + \Delta \psi(\boldsymbol{\rho}', \hat{\boldsymbol{s}}^{\text{in}}(\boldsymbol{\rho}'))) \mapsto \psi^{\text{out}}(\boldsymbol{\rho})$

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Wavefront phase response: $\psi^{in}(\rho') + \Delta \psi(\rho', \hat{s}^{in}(\rho'))) \mapsto \psi^{out}(\rho)$

- Response given by Fresnel's equations
- Field response: S matrix

$$\underline{\mathbf{b}}(\boldsymbol{\alpha})\boldsymbol{U}^{\mathrm{in}} \mapsto |\boldsymbol{U}^{\mathrm{out}}| \text{ (TM mode)} \quad \Rightarrow \quad \text{Transmittance } T(\boldsymbol{\alpha})$$





Wavefront phase response: $\psi^{\text{in}}(\rho') + \Delta \psi(\rho', \hat{s}^{\text{in}}(\rho'))) \mapsto \psi^{\text{out}}(\rho)$

- Response given by Fresnel's equations
- Field response: S matrix

Transmission: $\Delta \psi(\boldsymbol{\alpha})$ (TM mode)





Wavefront phase response: $\psi^{in}(\rho') + \Delta \psi(\rho', \hat{s}^{in}(\rho'))) \mapsto \psi^{out}(\rho)$

- Response given by Fresnel's equations
- Field response: S matrix

Reflection: $\Delta \psi(\boldsymbol{\alpha})$ (TM mode)





 $\begin{array}{ll} \textbf{U-field response:} \quad \underline{b}(\rho', \hat{s}^{\text{in}}(\rho')) U^{\text{in}}(\rho') \mapsto U^{\text{out}}(\rho) \\ \\ \textbf{Wavefront phase response:} \quad \psi^{\text{in}}(\rho') + \Delta \psi(\rho', \hat{s}^{\text{in}}(\rho'))) \mapsto \psi^{\text{out}}(\rho) \end{array}$

Surfaces between Dielectrics (Transmisson):

 $\Delta \psi \stackrel{!}{=} 0$

- Wavefront response control not possible by surface effect!
- Wavefront control w/o structured layer requires CURVED surfaces.

Freeform Surface Design by Inverse Propagation



Calculate the surface $S \subset \mathbb{R}^3$ on which:

$$\psi^{\text{out,d}}(\boldsymbol{r}\in S) - \psi^{\text{in,d}}(\boldsymbol{r}\in S) = \Delta\psi(\boldsymbol{r}\in S) \stackrel{!}{=} 0$$

Freeform Surface Design by Inverse Propagation



Calculate the surface $S \subset \mathbb{R}^3$ on which:

$$\psi^{\text{out,d}}(\boldsymbol{r}\in S) - \psi^{\text{in,d}}(\boldsymbol{r}\in S) = \Delta\psi(\boldsymbol{r}\in S) \stackrel{!}{=} 0$$

scenario. Available surface representations include:

- Point cloud & B-Splines
- Zernike polynomials (recursive)
- Forbes polynomials
- Aspherical polynomial series
- Polynomial series

Proposed Design Workflow



Freeform Surface Design by Inverse Propagation



Calculate the surface $S \subset \mathbb{R}^3$ on which:

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Calculate the surface $S \subset \mathbb{R}^3$ on which:

$$\psi^{\text{out,d}}(\boldsymbol{r}\in S) - \psi^{\text{in,d}}(\boldsymbol{r}\in S) = \Delta\psi(\boldsymbol{r}\in S) \stackrel{!}{=} m \ 2\pi$$





Segmented Elements:

Surface designs with different m can be done in different segements of the ele-

Holographic Optical Elements (HOE):

 2π -modulo operation on wavefront phase and surface design per resulting zone.





Proposed Design Workflow



Design the system by introducing functional components to achieve the demanded system functionality.

STRUCTURAL DESIGN

Replace functional components by freeform or/and flat optics components.

MODELING & EVALUATION

- Freeform design
- Segmented components
- Fresnel lenses
- HOE

detectors and

OPTIMIZATION

TOLERANCING

Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

FABRICATION DATA

Use the modeling techniques to further optimize the system by, e.g. parametric optimization.

All surfaces are designed with the same technique and follow the same physical principles: Wavefront phase response is realized by local optical path length differences!



Phase response by surface effects?



U-field response: $\underline{\mathbf{b}}(\boldsymbol{\rho}', \hat{\boldsymbol{s}}^{\text{in}}(\boldsymbol{\rho}')) U^{\text{in}}(\boldsymbol{\rho}') \mapsto U^{\text{out}}(\boldsymbol{\rho})$ Wavefront phase response: $\psi^{\text{in}}(\boldsymbol{\rho}') + \Delta \psi(\boldsymbol{\rho}', \hat{\boldsymbol{s}}^{\text{in}}(\boldsymbol{\rho}'))) \mapsto \psi^{\text{out}}(\boldsymbol{\rho})$

- Response given by Fresnel's equations
- Field response: S matrix



U-field response: $\underline{\mathbf{b}}(\boldsymbol{\rho}', \hat{\boldsymbol{s}}^{\text{in}}(\boldsymbol{\rho}')) U^{\text{in}}(\boldsymbol{\rho}') \mapsto U^{\text{out}}(\boldsymbol{\rho})$ Wavefront phase response: $\psi^{\text{in}}(\boldsymbol{\rho}') + \Delta \psi(\boldsymbol{\rho}', \hat{\boldsymbol{s}}^{\text{in}}(\boldsymbol{\rho}'))) \mapsto \psi^{\text{out}}(\boldsymbol{\rho})$

• Field response: S matrix



Transmission: $\Delta \psi(\alpha)$ (TE mode)



Transmission: $\Delta \psi(\alpha)$ (TE mode)



- Functional design provides $\Delta \psi (oldsymbol{
 ho}, oldsymbol{\hat{s}}^{ ext{in}}(oldsymbol{
 ho})).$
- Structure design: Search for local layer at a location ρ , which provides demanded $\Delta \psi$ for local incident direction $\hat{s}^{in}(\rho)$.



Transmission: $\Delta \psi(\alpha)$ (TE mode)

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Transmission: $\Delta \psi(\alpha)$ (TE mode)

- Functional design provides $\Delta \psi (\boldsymbol{\rho}, \boldsymbol{\hat{s}}^{\mathrm{in}}(\boldsymbol{\rho})).$
- Structure design: Search for local layer at a location ρ , which provides demanded $\Delta \psi$ for local incident direction $\hat{s}^{in}(\rho)$.
- Per location a suitable layer must be found. Fabrication not practical!
- Metasurfaces: Phase effect by layer which consists of laterally modulated local cells.

- • × 2: Fresnel Effects Calculator First Material Tables Diagram Name Fused_Silica Q Parameters Polarization × / 2 Abscissa(e) Incidence Angle Catalog Material Transverse Electric (TE) 532 nm Solid State of Matte Wavelength Coefficient Angle of Incidence 0° 89.999 Transmission Coeff (Phase / ~ Swap Materials Second Material Name Air Q ~ / 📔 Catalog Material [rad] State of Matter Gas or Vacuum (Phase) [-Coating Name OB-AR625-655 Coeff 0 X $\Delta \psi(30^{\circ})$ **Transmission** -Coating Orientation - Automatic Decision N Second Material terial 3 40 50 60 70 80 10 20 30 Incidence Angle α (for λ =532 nm) [°] Incident angle α Validity: 🕑 Close Help

Transmission: $\Delta \psi(\boldsymbol{\alpha})$ (TE mode)

- Functional design provides $\Delta \psi (\boldsymbol{\rho}, \hat{\boldsymbol{s}}^{\mathrm{in}}(\boldsymbol{\rho})).$
- Structure design: Search for local layer at a location ρ , which provides demanded $\Delta \psi$ for local incident direction $\hat{s}^{in}(\rho)$.
- Per location a suitable layer must be found. Fabrication not practical!
- Metasurfaces: Phase effect by layer which consists of laterally modulated local cells.

COMMENT https://doi.org/10.1038/s41467-020-15972-9 OPEN

The advantages of metalenses over diffractive lenses

Jacob Engelberg [●] ¹ & Uriel Levy [●] ^{1⊠}

Nature Communication, April 2020



Fig. 2 Scanning electron microscope (SEM) images of several metalens antenna forms. a Nano-fins used for geometrical phase, reproduced with permission from ref. ⁹, Copyright 2016 AAAS. (b) Nano-rods used as truncated waveguides, reproduced with permission from ref. ⁷, Springer Nature and c Nano-disks used for Huygens metalens, reproduced with permission from ref. ¹², De Gruyter. Scale bar is 1 μm.

Analysis of Phase Response of Metasurface Unit Cell



Design of Metasurface for Specified Phase Response



Proposed Design Workflow



Design the system by introducing functional components to achieve the demanded system functionality.

STRUCTURAL DESIGN

Replace functional components by freeform or/and flat optics components.

MODELING &

FURTHER

- Freeform design
- Segmented components
- Fresnel lenses
- HOE
- Metasurfaces

detectors and

merit functions.

SYSTEM TOLERANCING

Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

Fabrication Data

Use the modeling techniques to further optimize the system by, e.g. parametric optimization.

Proposed Design Workflow

FUNCTIONAL DESIGN

Design the system by introducing functional components to achieve the demanded system functionality.

STRUCTURAL DESIGN

Replace functional components by freeform or/and flat optics components.

MODELING & EVALUATION

Model the system with ray tracing and physical optics. Evaluate the performance by suitable detectors and merit functions.



Modeling

Modeling and evaluation of performance of surfaces which are obtained by structure design

Freeform Surface: Modeling



• Local application of S-matrix for curved surfaces: Local Plane Interface Approximation (LPIA).



Physical-optics propagation through curved surfaces

Rui Shi,^{1,2,*} Christian Hellmann,³ and Frank Wyrowski¹

¹Applied Computational Optics Group, Friedrich Schiller University Jena, Jena, Germany ²LightTrans International UG, Jena, Germany ³Wyrowski Photonics UG, Jena, Germany ^{*}Corresponding author: rui.shi@uni-jena.de



Segmented Surface: Modeling



• Local application of S-matrix for curved surfaces: Local Plane Interface Approximation (LPIA).



Holographic Optical Element: Modeling



• Local application of S-matrix for curved surfaces: Local Plane Interface Approximation (LPIA).



Holographic Optical Element: Modeling



HOE Modeling: Local Integration



U-field response in outer zones is affected by the neighborhood in structure: **local grating**

Field response must be calculated by local application of the rigorous Fourier Modal Method (FMM) to include all effects: Local Linear Grating Approach (LLGA)



Metasurface Modeling: Full Integration Over Lens Diameter


Metasurface Modeling: Full Integration Over Lens Diameter

•



Metasurface Modeling: Local Integration

•



Metasurface Modeling: Local Integration Level I



- Full integration requires too high numerical effort for metasurfaces of reasonable size.
- However, local integration sufficient and much more efficient!

Locally we assume subwavelength grating with local pillar size.

Metasurface Modeling: Local Integration Level II

•



Stitching method by benefiting from local reach of evanescent fields.

Metasurface Modeling: Local Integration Level II



Metasurface Modeling: Local Integration Level II



Proposed Design Workflow

FUNCTIONAL DESIGN

Design the system by introducing functional components to achieve the demanded system functionality.

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Replace functional components by freeform or/and flat optics components.

MODELING & EVALUATION

Model the system with ray tracing and physical optics. Evaluate the performance by suitable detectors and merit functions.



Example Focusing

Structural Design

Functional Design: Focusing (NA = 0.2) – Ray Tracing



Structural Design Freeform: Focusing (NA = 0.2)



Focusing (NA = 0.2) Lens: Ray Tracing



Remark



Focusing (NA = 0.2) Lens: Ray Tracing







Energy Density in Focus (False Color)

MTF

Efficiency: 91.1% (efficiency after first plane: 96.5%)





Amplitude after lens

Amplitude after lens



Wavefront phase after lens



Wavefront phase error after lens

Focusing (NA = 0.4) – Functional Design



Structural Design Freeform: Focusing (NA = 0.4)



Focusing (NA = 0.4) Lens: Ray Tracing







Energy Density in Focus (False Color)

MTF

Efficiency: 84.98% (efficiency after first plane: 96.5%)



Energy Density in Focus (False Color)



Fresnel effect at surface

Efficiency: 84.98% (efficiency after first plane: 96.5%)





Amplitude after lens

Amplitude after lens



Wavefront phase after lens



Wavefront phase error after lens

Structural Design Segmented: Focusing (NA = 0.4)



Focusing (NA = 0.4) Lens: Ray Tracing





Structural Design Segmented Lens: Focusing NA 0.4

Preview for Programmable Surface	- 🗆 X
	Q 🕂 <mark>Ə</mark> : :
	HI THE H
Z X Y	<u> 2 mm</u> − 1
Z-Extension Extension 1.08528813196249 mm Minimum -1.08528813196249 mm Maximum	m 4.33680868994202E-1
	Close Help



Energy Density in Focus (False Color)



MTF



Wavefront Phase after Segmented Lens



Wavefront Error after Segmented Lens

Near Field Analysis – 500µm after Segmented Lens:



Field (Ex) @ 500µm after Lens (Outer Segment) Field (Ex) @ 500µm after Lens (Inner Segment) Field (Ex) @ 500µm after Lens (Combined)

Near Field Analysis – 500µm after Segmented Lens:



Near Field Analysis – 500µm after Segmented Lens:



Near Field Analysis – 500µm after Segmented Lens:



Near Field Analysis – 500µm after Segmented Lens:



Field (Ex) @ 500µm after Lens (Outer Segment) Field (Ex) @ 500µm after Lens (Inner Segment) Field (Ex) @ 500µm after Lens (Combined)

Structural Design HOE: Focusing (NA = 0.2)



Focusing (NA = 0.2) HOE: Ray Tracing






Field in Focus (False Color)

MTF

Efficiency: 78.99% (Efficiency after First Plane: 96.5%)





Amplitude after HOE

Amplitude after HOE



5: "Electromagnetic Field Detector" (# 603) after "HOE" (# 6) (T) (Field Tracing) Electric Field Diagram Table Value at (x.y) '15Phase of "Ex-Component" [rad] 4 ŝ 2 [mm] -0.20481 \geq 2 ņ 4 -0.40962 7 -5 -4 -3 -2 -1 0 1 2 3 4 5 X [mm]

Wavefront Error after HOE

Wavefront after HOE

Focusing (NA = 0.4) HOE: Ray Tracing



Grating Profile for HOE: Four Level







Energy Density in Focus (False Color)

MTF

Efficiency: 65.17% (efficiency after first plane: 96.5%)





Amplitude after HOE

Amplitude after HOE



12: "Electromagnetic Field Detector" (# 603) after "HOE" (# 6) (T) (Field Tracing) Electric Field Diagram Table Value at (x.y) '13Phase of "Ex-Component" [rad] 0.06702 4 0 0 [mm] > 2 ņ 4 . Ю -0.40458 -5 -4 -3 -2 -1 0 2 3 4 5 X [mm]

Wavefront Error after HOE

Wavefront after HOE

Focusing (NA = 0.4) HOE: Field Tracing \rightarrow -1st, 0th, +1st



Order HOE	Efficiency after HOE
-3	0.98%
-2	3.51%
-1	5.31%
0	3.46%
1	65.17%
2	6.17%
3	0.31%

Energy Density in Focus (False Color)



Efficiencies vs. Period



Amplitude after HOE



Efficiencies vs. Period

Focusing (NA = 0.4) HOE: Field Tracing \rightarrow -1st, 0th, +1st



279: D:\OneDrive\...\2021-01-10_Christian_Hellmann_Focusing_532nm_NA0.4_CombinedMTF_wHigherOrders.da Numerical Data Array Diagram Table Value at x-Coordinate 0.9 0.8 0.7 ŧ 0.6 #2, MTF (HOE with Higher Orders) Ô, 0.5 MTF (Functional) Subsets — MTF (HOE) 0.4 0.3 0.2 0.1 0.2 0.4 0.6 0.8 1 1.2 1.4 1.6 1.8 2 2.2 2.4 2.6 2.8 Line Density X [1E3 cycles/mm]

Energy Density in Focus (False Color)

MTF

Design of Metasurface for Specified Phase Response







Energy Density in Focus (False Color)

Efficiency: 93.64% (Efficiency after First Plane: 96.5%)





Energy Density in Focus (False Color)

Efficiency: 93.64% (Efficiency after First Plane: 96.5%)



Wavefront after Meta Lens



Wavefront Error after Meta Lens



Example Expander

Structural Design

Structural Design Beam Expander (1:5): Freeform + HOE



Structural Design Beam Expander (1:5): Freeform + HOE



Beam Expander (1:5) Lens + HOE: Ray Tracing



Beam Expander (1:5) Lens + HOE: Field Tracing



Amplitude after Beam Expander

Phase after Beam Expander

Efficiency of Freeform: 93.09% Efficiency of HOE: 77.15% System Efficiency: 71.82%

Beam Expander (1:10) – Functional Design: Ray Tracing



Structural Design Beam Expander (1:10): Lens + Lens



Beam Expander (1:10) – Structural Design: Lens



Beam Expander (1:10) Lens + Lens: Ray Tracing



Beam Expander (1:10) Lens + Lens: Field Tracing



Amplitude after Beam Expander

Phase after Beam Expander

Efficiency of Freeform #1: 89.53% Efficiency of Freeform #2: 89.53% System Efficiency: 80.16%

Beam Expander (1:10) Lens + Lens: Field Tracing



Amplitude after Beam Expander

Irradiance shaping satisfying because of symmetric situation.

Iterative design not needed.

Efficiency of Freeform #1: 89.53% Efficiency of Freeform #2: 89.53% System Efficiency: 80.16%

Example Fiber Coupling

Structural Design

Laser Diode Coupling Into Fiber: Functional Design



Laser Diode Coupling Into Fiber: Freeform Design



Laser Diode Coupling Into Fiber: Ray and Field Tracing



Example Shaping Expander

Structural Design

Shaping Beam Expander: Functional Design





Irradiance (by field tracing)

Structural Design Shaping Expander: One Freeform



Shaping Beam Expander Freeform + Functional: Ray Tracing


Shaping Beam Expander Freeform + Functional: Field Tracing





Irradiance (by field tracing)

Structural Design Shaping Expander: Two Freeforms



Shaping Expander Two Freeforms: Ray Tracing







" (# 609) after "Expander (Phase #2) Output Plane" (# 10) (T) (Field Tracing)

Irradiance (by field tracing)

Shaping Expander Two Freeforms: Field Tracing

Shaping Expander Two Freeforms: Field Tracing

Significant irradiance shaping often requires iterative optimization by several cycles of design workflow.



Irradiance (by field tracing)

FUNCTIONAL DESIGN

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STRUCTURAL DESIGN

Replace functional components by freeform or/and flat optics components.

MODELING & EVALUATION

Model the system with ray tracing and physical optics. Evaluate the performance by suitable detectors and merit functions.

FURTHER OPTIMIZATION

Use the modeling techniques to further optimize the system by, e.g., parametric optimization.

SYSTEM TOLERANCING

Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

FABRICATION DATA

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FABRICATION DATA

HOE Fabrication Data Export

Edit Holographic Optical Element Component	×
Edit Holographic Optical Element Component Solid Channel Operator Diffractive Structure Model Orderate Idealized Grating Structure Image: Coordinate Systems Systems Design Wavelength 532 nm Height Scaling Factor 1 Wuse Profile Quantization 2 v Number of Height Levels 2 v Orders for Simulation Order Order for Simulation Remove Order	× Structure export for quantized height structures can be performed by clicking on the corresponding button in the edit dialog of the HOE.
Channel Configuration	

HOE Fabrication Data Export

Configure Fabrication Export X
Output File(s) Path D:\FabricationData\ File Names (Without Extension) Export_Data
Mask Decomposition Settings Invert File Name Convention Ascending
Export Settings Export Type
Sampling Distance 20 µm x 20 µm
Export as
Bitmap (*.bmp) ASCII (*.txt) Plain Text (*.ptf)
CIF (*.cif) GDSII (*.gds)
Summary Files
ASCII file (*.txt) XML file (*.xml)
HTML file (*.html)
Go!
Die Preview Close

- Fabrication export supports specification of
 - Target directory
 - Parameters for mask decomposition
 - Pixelated or polygon data export (+ export accuracy parameters)
 - File format (supported formats: bitmap, text files, GDISII or CIF)

HOE Fabrication Data Export – Sample Data Pixelated Bitmap

Configure Fabrication Export X	
Output File(s) D:\FabricationData\ Select Path D:\FabricationData\ Select File Names (Without Extension) Export_Data .*	
Mask Decomposition Settings Invert File Name Convention Ascending ✓	
Export Settings Export Type Pixelated Data Export O Polygon Data Export Sampling Distance 500 nm x 500 nm	
Export as Export as Bitmap (*.bmp) CIF (*.cif) GDSII (*.gds) Export as Export	
Summary Files ASCII file (*.txt) XML file (*.xml)	
HTML file (*.html) Rich Text Format (*.rtf)	
Go!	
Deview Close	

HOE Fabrication Data Export – Sample Data Pixelated GDSII

onfigure Fabrication Export	×
Output File(s)	
Path	D:\FabricationData\ Select
File Names (Without Extension)	Export_Data .*
Mask Decomposition Settings	
✓ Invert	File Name Convention Ascending 🗸 👔
Export Settings	
Export Type Pixelat	ted Data Export O Polygon Data Export
Sampling Distance	500 nm x 500 nm
Export as	
Bitmap (*.bmp)	ASCII (*.txt) Plain Text (*.ptf)
CIF (*.cif)	GDSII (*.gds)
Summary Files	
ASCII file (*.txt)	XML file (*.xml)
HTML file (*.html)	Rich Text Format (*.rtf)
	▶ Go! ■
Deview	Close



HOE Fabrication Data Export – Sample Data Pixelated GDSII



HOE Fabrication Data Export – Sample Data Polygon CIF

Configure Fabrication Export	×
Output File(s) Path File Names (Without Extension)	D:\FabricationData\ Select Export_Data .*
Mask Decomposition Settings	File Name Convention Ascending 🗸 i
Export Settings Export Type O Pixelated	d Data Export Polygon Data Export
Polygon Detection Accuracy (i) Maximum Number of Points per P	b00 ← Accuracy (λ/i) = 1.064 nm
CIF (*.cif)	GDSII (*.gds)
ASCII file (*.txt)	✓ XML file (*.xml)
HTML file (*.html)	Rich Text Format (*.rtf)
	▶ Go!
3 Preview	Close



HOE Fabrication Data Export – Sample Data Polygon CIF





Freeform and Flat Optics: Why?



Freeform and flat optics introduce new design freedoms:

- Improve performance
- Reduce size and weight
- Less components
- Cost reduction
- Add new functionality, e.g., bifocal lenses, polarization dependency, ...

"Is it possible to replace a bulky glass system by one meta lens" ?

Imaging With One Component

Multifield scenario!

Imaging with One Component: Scenario



Imaging with One Component: Functional Design



Wavefront Response Component (Multifield): Ray Tracing



Wavefront Response Component (Multifield): Field Tracing





Wavefront Response Component (Multifield): Field Tracing





Wavefront Response Component (Multifield): Field Tracing





How can the component select the correct wavefront response per field?

Answer: **Angular multiplexing** via the dependency $\Delta \psi(\alpha_i^{\text{in}})$ of the local incident angle α .



How can the component select the correct wavefront response per field?







 $\Delta \psi \left(\boldsymbol{\rho}, \alpha_j^{\mathrm{in}}(\boldsymbol{\rho}) \right)$

🛃 37: De	lta PSI v	s. Incident Angle								
Numerical Data Array										
Diagram	Table	Value at x-Coordinate								
	-									
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	Incident Angle [°] $o(\frac{\ln}{2})$									
	$\alpha_j(\mathbf{P})$									



 $\Delta \psi \left(\boldsymbol{\rho}, \alpha_{j}^{\mathrm{in}}(\boldsymbol{\rho}) \right)$

🛃 17: Delta PSI vs. Incident Angle										×		
Numerical Data Array												
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	Incident Angle [°] $ain(a)$											
	$\alpha_{j}(\boldsymbol{p})$											



 $\Delta \psi \left(\boldsymbol{\rho}, \alpha_{j}^{\mathrm{in}}(\boldsymbol{\rho}) \right)$





 $\Delta \psi \left(\boldsymbol{\rho}, \alpha_{j}^{\mathrm{in}}(\boldsymbol{\rho}) \right)$





 $\Delta \psi \left(\boldsymbol{\rho}, \alpha_{j}^{\mathrm{in}}(\boldsymbol{\rho}) \right)$





 $\Delta \psi \left(\boldsymbol{\rho}, \alpha_{j}^{\mathrm{in}}(\boldsymbol{\rho}) \right)$








Metastructure: Efficiency & Phase vs Incident Angle (Heights)



Metastructure: Efficiency & Phase vs Incident Angle (Heights)



Metastructure: Efficiency & Phase vs Incident Angle (Diameters)





Must be highly nanostructured cells to introduce enough freedoms for structural design!





VirtualLab FUSIC

VirtualLab Fusion 2021

- Potential for going beyond "conventional surfaces" exists.
- Also restricted control of angle dependency of interest.

FUNCTIONAL DESIGN

Design the system by introducing functional components to achieve the demanded system functionality.

STRUCTURAL DESIGN

Replace functional components by smooth surface or flat optics components.

MODELING & EVALUATION

Model the system with ray tracing and physical optics. Evaluate the performance by suitable detectors and merit functions.

FURTHER OPTIMIZATION

Use the modeling techniques to further optimize the system by, e.g., parametric optimization.

SYSTEM TOLERANCING

Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

FABRICATION DATA

Calculate and export fabrication data from the surfaces which result from structural design and optimization.

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Zemax® enables functional design of a wavefront phase response (binary surfaces) by parametric optimization

 $\Delta \psi (\boldsymbol{\rho}, \alpha_j^{\mathrm{in}}(\boldsymbol{\rho})) \longrightarrow \Delta \psi (\boldsymbol{\rho})$

Design Workflow in VirtualLab Fusion

FUNCTIONAL DESIGN

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FABRICATION DATA

Calculate and export fabrication data from the surfaces which result from structural design and optimization.

Import of Zemax file into VirtualLab Fusion and further processing of workflow.





Design and Analysis of a Hybrid Eyepiece for Correction of Chromatic Aberration

Functional design in Zemax® OpticStudio®

Modeling and Design Scenario



Design of Wavefront Surface Response in OpticStudio





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Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

FABRICATION DATA

Use the modeling techniques to further optimize the system by, e.g. parametric optimization.

Import of Zemax file into VirtualLab Fusion and further processing of workflow.



On-Axis Analysis: Comparison of Spot Diagram







On-Axis Analysis: Comparison of PSF







On-Axis Analysis: Comparison of MTF









Off-Axis Analysis: Comparison of Spot Diagram







Off-Axis Analysis: Comparison of PSF







Off-Axis Analysis: Comparison of MTF









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Import of Zemax file into VirtualLab Fusion and further processing of workflow.



On-Axis Analysis: Inclusion of Higher Orders



simulation time per order ~seconds





+1st diffraction order

0th diffraction order

X [µm]

-30 -20 -10 0 10

∝ Electric Energy Density

 $[1E3 (V/m)^2]$

-20

000

50

0

10

-20

30

[mr] >

0

X [µm]

20

20 30

3.96

1.98

3....E-05

20

ر [سام] ک

-20

-20

(m¹), (m²), (m²)

0

X [µm]

20

∝ Electric Energy Density

 $[(V/m)^2]$

64.8

33.1

1.51

-1st diffraction order

Off-Axis Analysis: Inclusion of Higher Orders











FUNCTIONAL DESIGN

Design the system by introducing functional components to achieve the demanded system functionality.

STRUCTURAL DESIGN

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FURTHER OPTIMIZATION

Use the modeling techniques to further optimize the system by, e.g., parametric optimization.

SYSTEM TOLERANCING

Investigate the fabrication tolerances of components and the adjustment sensitivity of the system.

FABRICATION DATA

Use the modeling techniques to further optimize the system by, e.g. parametric optimization.

Import of Zemax file into VirtualLab Fusion and further processing of workflow.



Conclusion

- Freeform and flat optics provide additional design freedoms for optical design.
- Potential of these techniques to be further investigated. We provide tools for this investigation.
- We propose a workflow which is based on physical optics and includes ray optics:



 All presented techniques available in-house and to be released in 2021.





VirtualLab Fusion 2021